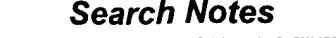


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/612,995	TSUMURA ET AL.
	Examiner	Art Unit
	DUC Q. DINH	2674

SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner